

Application/Control No.	Applicant(s)/Patent under Reexamination							
10/043,368	FARWELL, WILLIAM D.							
Examiner	Art Unit	_						
Tse Chen	2116							

				IS	SUE C	LASSIF	ICATIO	N								
ORIGINAL						CROSS REFERENCE(S)										
CLASS SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
713 300			713	310												
INTE	RNAT	ONAL	CLASSIFICATION													
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•	(As	sistant	Examiner) (Da	1/9/05		PERVISORY		Total Claims Allowed: 18								
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⊠c	Claims renumbered in the same order as presented by applicant								cant	□СРА			☐ T.D.			☐ R.1.47			
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
	1			31			61			91			121			151			181
	2			32			62			92			122			152			182
	3			33			63			93			123			153			183
	4			34			64			94			124			154			184
	5			35			65			95			125			155			185
	6			36			66			96			126			156			186
	7			37			67			97			127			157			187
	8]		38			68]		98			128			158			188
	9			39			69	1		99			129			159			189
	10] :		40			70			100			130			160			190
	11	1		41			71			101			131			161			191
	12	1		42			72			102			132			162			192
	13			43			73			103			133			163			193
	14			44			74]		104			134			164			194
	15			45			75			105			135	ı		165			195
	16)		46			76			106			136			166			196
	17	1		47			77]		107			137			167			197
	18	1		48			78	1		108			138			168			198
	19			49			79	1		109			139			169			199
	20	1		50			80]		110			140			170)		200
	21			51			81			111			141			171]		201
	22]		52			82			112			142			172			202
	23			53			83]		113			143			173			203
	24	1		54			84]		114			144			174]		204
	25			55]		85	1		115			145			175			205
	26			56			86]		116			146			176]		206
	27]		57]		87]		117			147			177			207
	28]		58]		88			118			148			178			208
	29]		59]		89			119			149			179			209
	30]		60			90			120			150			180	<u> </u>		210